

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Patent Application Serial No. .... Unknown  
 Filing Date ..... Filed Herewith  
 Inventor ..... Garo J. Derderian et al.  
 Assignee ..... Micron Technology, Inc.  
 Group Art Unit ..... Unknown  
 Examiner ..... Unknown  
 Attorney Docket No. .... MI22-2444  
 Customer No. .... 021567  
 Title ..... Methods of Forming Trench Isolation Regions

**INFORMATION DISCLOSURE STATEMENT**

References -- See Attached Form PTO-1449

The attached form PTO-1449 is submitted in compliance with 37 CFR §1.56. Pursuant to 1276 OG 55, August 5, 2003, no copies of cited U.S. patents or U.S. patent application publications are included herewith, as the date of filing of this patent application occurs after June 30, 2003. No admission is made regarding whether all the listed references are prior art.

Respectfully submitted,

Dated: 4/1/04By: 

David G. Latwesen  
 Reg. No. 38,533

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| Form PTO-1449   |  | U.S. DEPARTMENT OF COMMERCE<br>PATENT AND TRADEMARK OFFICE |  | ATTY. DOCKET NO.<br>MI22-2444       |  | SERIAL NO.<br>Unknown |  |
| LIST OF ART CITED BY APPLICANT<br>(Use several sheets if necessary) |  |  |  | APPLICANT: Garo J. Derderian et al. |  |                       |  |
|   |  |  |  | FILING DATE<br>Filed Herewith       |  | GROUP<br>Unknown      |  |

  

| U.S. PATENT DOCUMENTS   |    |                 |          |                  |       |          |                               |
|-------------------------|----|-----------------|----------|------------------|-------|----------|-------------------------------|
| *Examiner's<br>Initials |    | Document Number | Date     | Name             | Class | Subclass | Filing Date<br>If Appropriate |
|                         | AA | 5,393,694       | 02/28/95 | Mathews          |       |          |                               |
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|                          |    | Document Number | Date | Country | Class | Subclass | Translation |    |
|                          |    |                 |      |         |       |          | Yes         | No |
|                          | AJ |                 |      |         |       |          |             |    |
|                          | AK |                 |      |         |       |          |             |    |
|                          | AL |                 |      |         |       |          |             |    |

  

| OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.) |    |                 |  |
|---|----|-----------------|--|
|   | AM |                 |  |
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|   |    |                 |  |
|   | AO |                 |  |
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| EXAMINER  |    | DATE CONSIDERED |  |

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.